	Search Notes
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/032,729	CHEN ET AL.	
Examiner	Art Unit	
Gregory B. Sefcheck	2616	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
SEE PR	INTOUT	2/2/07	6BS	
		,		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST SEARCH	2/2/07	685		
370/389,390,395.7, 395.72,412,428, 429, 711/100 (text only)				
PALM INVENTOR SEARCH	2/2/07	685		
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